

Notice of References Cited	Application/Control No. 10/644,948		Applicant(s)/Patent Under Reexamination FU, JENNIFER JIE	
	Examiner TuyetLien (Lien) T. Tran		Art Unit 2179	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,764,913 A	06-1998	Jancke et al.	709/224
*	B	US-6,330,005 B1	12-2001	Tonelli et al.	715/735
*	C	US-2002/0024535 A1	02-2002	Ueno et al.	345/736
*	D	US-2002/0052941 A1	05-2002	Patterson, Martin	709/223
*	E	US-6,681,232 B1	01-2004	Sistanizadeh et al.	707/104.1
*	F	US-6,754,703 B1	06-2004	Spring, Maximilian J.	709/223
*	G	US-6,952,208 B1	10-2005	Arquie et al.	345/440
*	H	US-6,983,227 B1	01-2006	Thalhammer-Reyero, Cristina	703/2
*	I	US-7,039,870 B2	05-2006	Takaoka et al.	715/736
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.